IEEE All-Society Periodicals Package

IEEE Xplore[®] Digital Library Subscription Option

Essential research journals from IEEE Societies

The IEEE All-Society Periodicals Package (ASPP) provides access to the core IEEE collection of technology journals. With peer-reviewed publications concentrating on theoretical and experimental papers, as well as practical applications in research, design, and specification, ASPP offers valuable research on a variety of topics.

IEEE All-Society Periodicals Package delivers key benefits for researchers:

- Drive new ideas, designs, and applications with cutting-edge research
- Develop better solutions faster by understanding the technology landscape
- Increase productivity by reviewing previous research without having to reinvent the wheel
- Accelerate innovation and patent development with convenient access to proven research all in one place
- Increase scholarly output and new research development
- Stay ahead of the technology curve with the latest publications

New subscription titles for 2024-2025*

- IEEE Electron Devices Reviews
- IEEE Energy Sustainability Magazine
- IEEE Reliability Magazine
- IEEE Robotics and Automation Practice
- IEEE Transactions on Circuits and Systems for Artificial Intelligence
- IEEE Transactions on Field Robotics
- IEEE Transactions on Materials for Electron Devices

*Listing current as of 09/2024 and is subject to change



Add quality, depth, and value to your institution's technology collection:

204 online IEEE Society-sponsored journals, magazines, and transactions

Unlimited, full-text access to more than 440,000 articles

Featuring content from Nokia's *Bell Labs Technical Journal* archive

Early access to articles accepted for future publication

Backfile to 2017

For a custom quote, contact an IEEE Sales Representative.

Subscribe Today

See how IEEE *Xplore* helps drive research and innovation Visit www.ieee.org/go/aspp



IEEE Xplore Digital Library • www.ieee.org/ieeexplore • onlinesupport@ieee.org

Delivered through the IEEE Xplore® Digital Library

Access respected technology research that generates results

IEEE *Xplore* includes **top-ranked journals and technology research that is cited in patents nearly three times more often than any other publisher.** With more than 6 million full-text documents, IEEE *Xplore* is your gateway to approximately 30% of the world's current literature in electrical engineering, electronics, and computing.

Find relevant research faster with powerful search tools

IEEE *Xplore* combines an easy-to-use interface with powerful search features that make finding relevant research faster and more efficient.

Search: With a robust search engine, Basic, Advanced, and Author search options and a "Refine/Expand Results" module let users modify and find results more easily.

Personalize: Users can also personalize IEEE *Xplore* to create targeted saved searches and table of contents alerts, and set personal preferences.

New Features: These include My Research Projects enhancements, My Favorite Journals & Magazines, Search History enhancements, and other personalization features; Image Search for IEL subscribers; and a new automated indexing process.



IEEE Xplore also provides:

- More than 6 million documents in full-text PDF format, with over four million in a robust, dynamic HTML format
- Multiple authentication options for on-site, remote, and mobile users
- Abstract/citation and bibliographic records for subscribed content
- Mobile-friendly design
- Daily content updates

Get the latest research in a wide range of technologies including:

- Aerospace and Defense
- Artificial Intelligence
- Biometrics
- Computer Hardware and Software
- Cyber Security
- Electronics
- Internet of Things (IoT)
- Medical Devices
- Nanotechnology
- Optics
- Power Engineering
- Robotics
- Semiconductors
- Smart Grid
- Telecommunications
- Wireless Technology

Subscribe Today

See how IEEE *Xplore* helps drive research and innovation Visit www.ieee.org/go/aspp Phone: +1 800 701 IEEE (4333) (USA/Canada)

+1 732 981 0060 (worldwide)



IEEE Xplore Digital Library • www.ieee.org/ieeexplore • onlinesupport@ieee.org